TOSHIBA

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (U-MOS III)

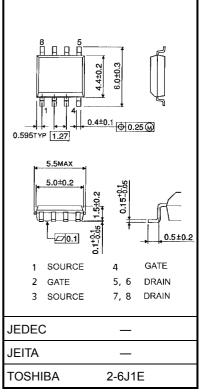
TPC8211

Lithium Ion Battery Applications Portable Equipment Applications Notebook PC Applications

- Low drain-source ON resistance: R_{DS} (ON) = 25 m Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = 7.0 \text{ S} (typ.)$
- Low leakage current: $I_{DSS} = 10 \ \mu A \ (max) \ (V_{DS} = 30 \ V)$
- Enhancement-mode: V_{th} = 1.3 to 2.5 V (V_{DS} = 10 V, I_D = 1 mA)

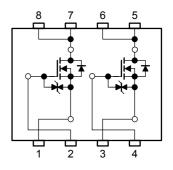
Maximum Ratings (Ta = 25°C)

Char	acteristics	Symbol	Rating	Unit	
Drain-source vol	tage	V _{DSS}	30	V	
Drain-gate voltag	ge (R _{GS} = 20 k Ω)	V _{DGR}	30	V	
Gate-source volt	age	V _{GSS}	±20	V	
Drain current	D C (Note 1)	ID	5.5	А	
Pulse (Note 1) IDP Drain power dissipation (t = 10 s) Single-device operation (Note 3a) PD (1)	22				
	operation	P _{D (1)}	1.5	W	
(t = 10 s)	Single-device value at dual operation (Note 3b)	P _{D(2)}	1.1		
Drain power dissipation (t = 10 s) (Note 2b)	Single-device operation (Note 3a)	P _{D (1)}	0.75	W	
	Single-device value at dual operation (Note 3b)	P _{D (2)}	0.45		
Single pulse ava	lanche energy (Note 4)	E _{AS}	39.3	mJ	
Avalanche curre	nt	I _{AR}	5.5	А	
Repetitive avalar Single-device va	nche energy lue at dual operation (Note 2a, 3b, 5)	E _{AR}	0.1	mJ	
Channel tempera	ature	T _{ch}	150	°C	
Storage tempera	ture range	T _{stg}	-55 to 150	°C	



Weight: 0.08 g (typ.)

Circuit Configuration



Note: For (Note 1), (Note 2), (Note 3), (Note 4) and (Note 5), please refer to the next page.

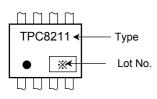
This transistor is an electrostatic sensitive device. Please handle with caution.

Unit: mm

Thermal Characteristics

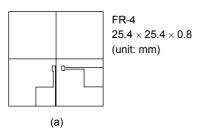
Characteristics	Symbol	Max	Unit		
	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	83.3		
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	Single-device value at dual operation (Note 3b)	R _{th (ch-a) (2)}	R _{th (ch-a) (2)} 114		
Thermal resistance, channel to ambient	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	167	°C/W	
(t = 10 s) (Note 2b)	Single-device value at dual operation (Note 3b)	R _{th (ch-a) (2)}	278		

Marking (Note 6)



Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2:



- a) Device mounted on a glass-epoxy board (a)

пп

FR-4

(unit: mm)

 $25.4\times25.4\times0.8$

b) Device mounted on a glass-epoxy board (b)

Note 3:

- a) The power dissipation and thermal resistance values are shown for a single device. (During single-device operation, power is only applied to one device.)
- b) The power dissipation and thermal resistance values are shown for a single device. (During dual operation, power is evenly applied to both devices.)
- Note 4: V_{DD} = 24 V, T_{ch} = 25°C (initial), L = 1.0 mH, R_G = 25 Ω , I_{AR} = 5.5 A

(Three digits)

- Note 5: Repetitive rating: pulse width limited by maximum channel temperature
- Note 6: on lower left of the marking indicates Pin 1.



Week of manufacture _(01 for first week of year, continues up to 52 or 53) -Year of manufacture

(One low-order digits of calendar year)

Electrical Characteristics (Ta = 25°C)

Charao	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μA
Drain cut-OFF	current	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V		_	10	μA
Drain-source br	oakdown voltago	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	30	—		V
Dialit-Source bi	eakuowii voitage	V (BR) DSS	$I_{\rm D}$ = 10 mA, V _{GS} = -20 V	15	_	_	v
Gate threshold	voltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	1.3	_	2.5	V
Drain-agurag O	N registeres	R _{DS (ON)}	V _{GS} = 4.5 V, I _D = 3 A	_	31	44	mΩ
Dialit-Source O	IN TESISLATICE	R _{DS (ON)}	V _{GS} = 10 V, I _D = 3 A	_	25	36	11122
Forward transfe	r admittance	Y _{fs}	V _{DS} = 10 V, I _D = 3 A	3.5	7.0	_	S
Input capacitant	ce	C _{iss}		_	1250	_	
Reverse transfer capacitance		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	155	_	pF
Output capacitance		C _{oss}		_	170	_	
Output capacitance Rise Turn- Switching time Fall ti Turn- Total gate charge (Gat plus gate-drain) Gate-source charge	Rise time	tr	$V_{GS} \stackrel{10}{_{0}} V \prod_{V} I_{D} = 3 A$	_	5	_	
	Turn-ON time	t _{on}			11		- ns
	Fall time	t _f			9	_	
	Turn-OFF time	t _{off}	Duty \leq 1%, t _w = 10 μ s	_	63	-	
Total gate charge (Gate-source plus gate-drain)		Qg	V _{DD} ≈ 24 V, V _{GS} = 10 V, I _D = 5.5 A	_	25	_	
Gate-source charge		Q _{gs}		—	20	—	nC
Gate-drain ("miller") charge		Q _{gd}		—	5	—	

Source-Drain Ratings and Characteristics (Ta = 25°C)

Characte	eristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I _{DRP}	—	_	_	22	А
Forward voltage (diode)	V _{DSF}	I _{DR} = 5.5 A, V _{GS} = 0 V	_	—	1.2	

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